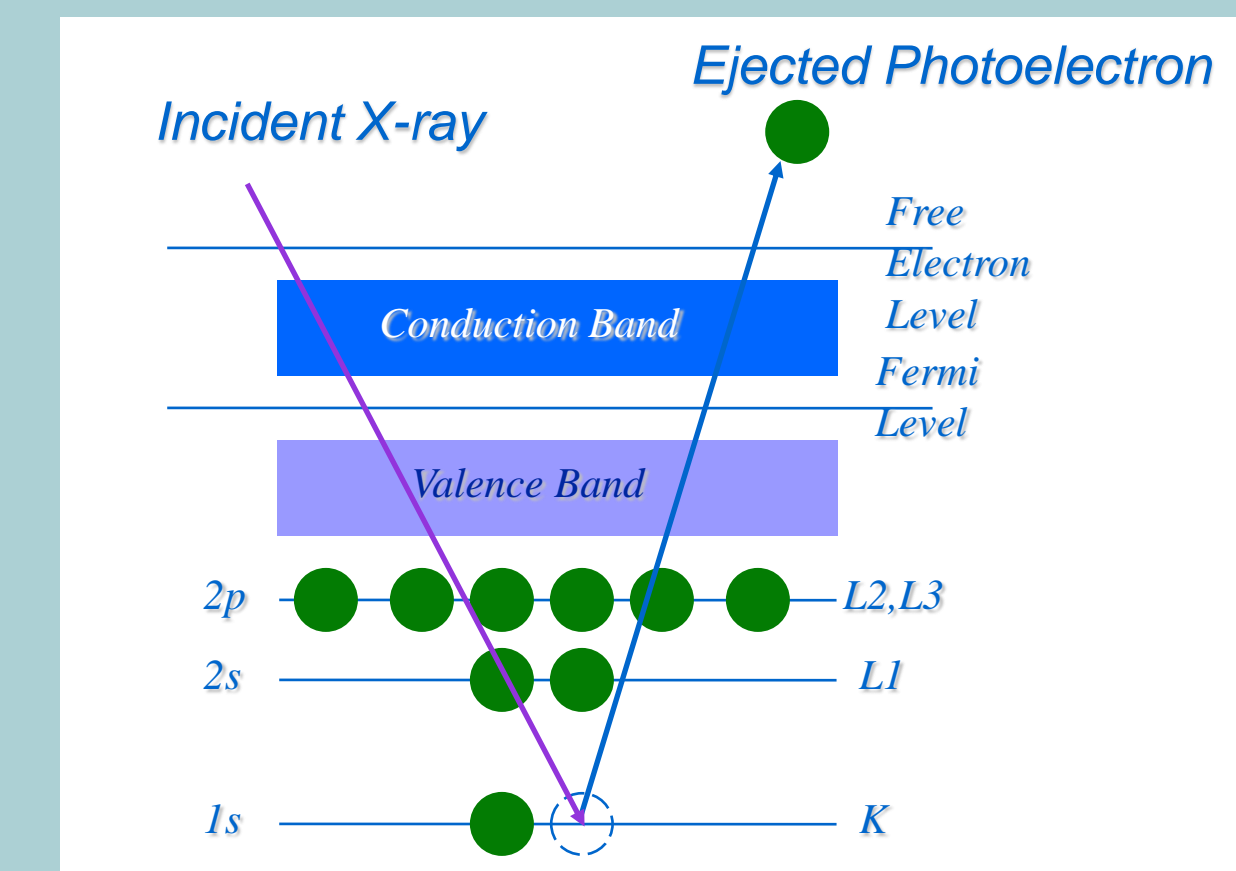
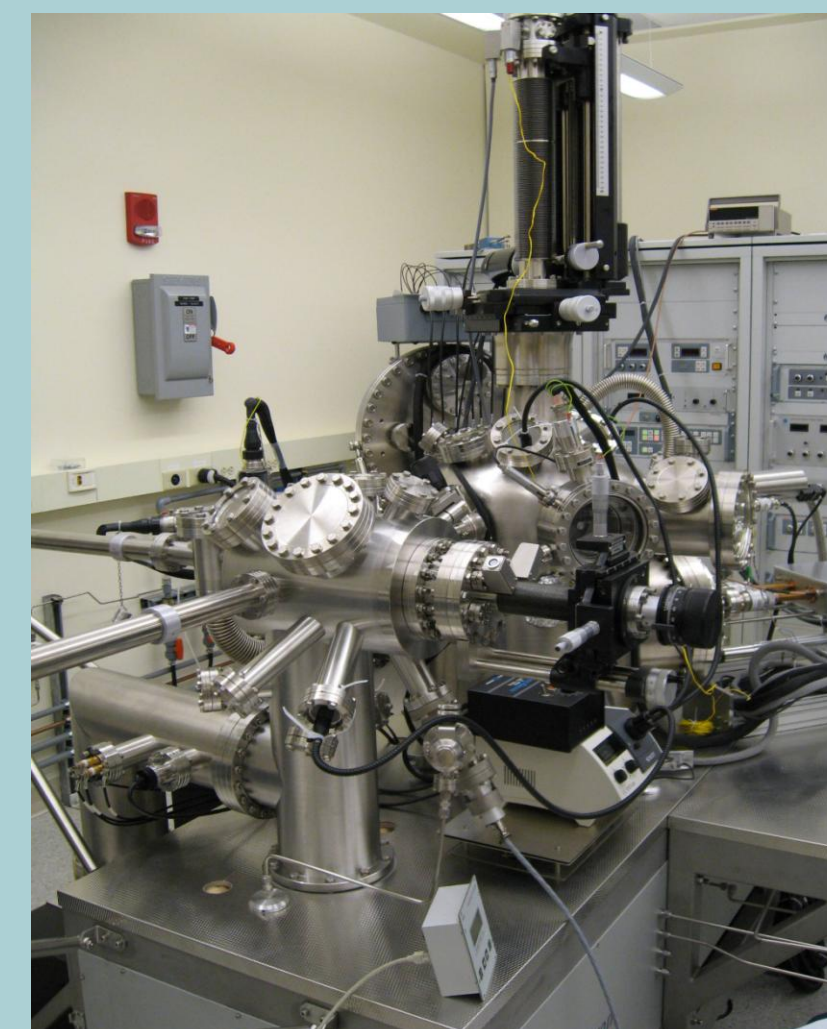


1 Surface Characterization Methods

X-ray Photoelectron Spectroscopy: The photoelectric process



- XPS spectral lines are identified by the shell from which the electron was ejected (1s, 2s, 2p, etc.).
- The ejected photoelectron has kinetic energy: $KE = hv - \text{Binding } E - \text{Work Function}$
- Energy of ejected photoelectron reveals characteristic information regarding the elemental composition of the substrate.



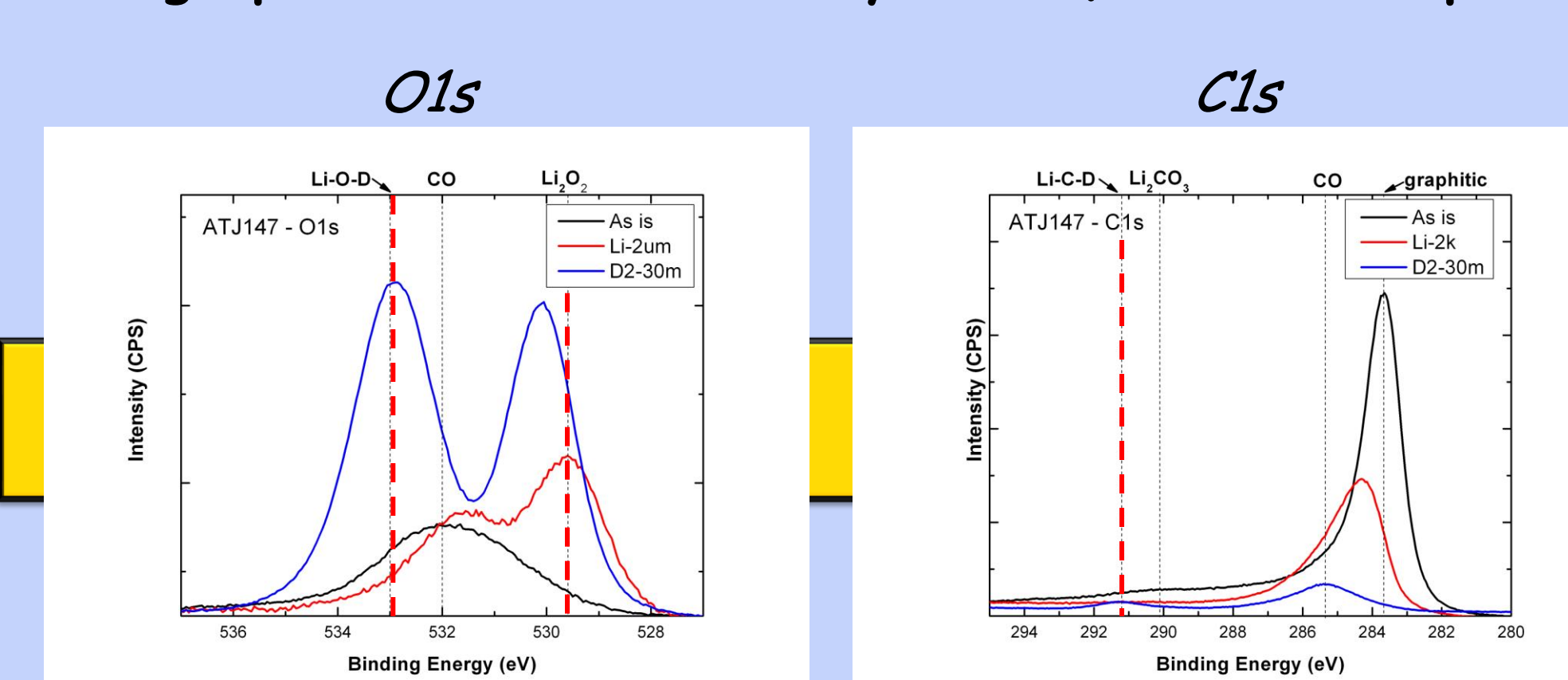
Omicron surface characterization cluster (Birck Nanotechnology Center)

Experiment Methods

- XPS performed before and after each process (dwell=0.8ms, step=0.05eV).
- Processes include:
 - Li deposition via lithium evaporator.
 - D⁺ bombardment (irradiation) (500 ev/amu).
 - Ar cleaning and annealing (550C) (if needed).

2 Deuterium-Lithium Surface Chemistry

ATJ graphite surface chemistry with 2µm lithium deposition and D⁺:



ATJ graphite sample substrate (black) with 2µm lithium conditioning (red), and 30 min deuterium bombardment (blue). Control studies isolate the effect of each process

What happens?

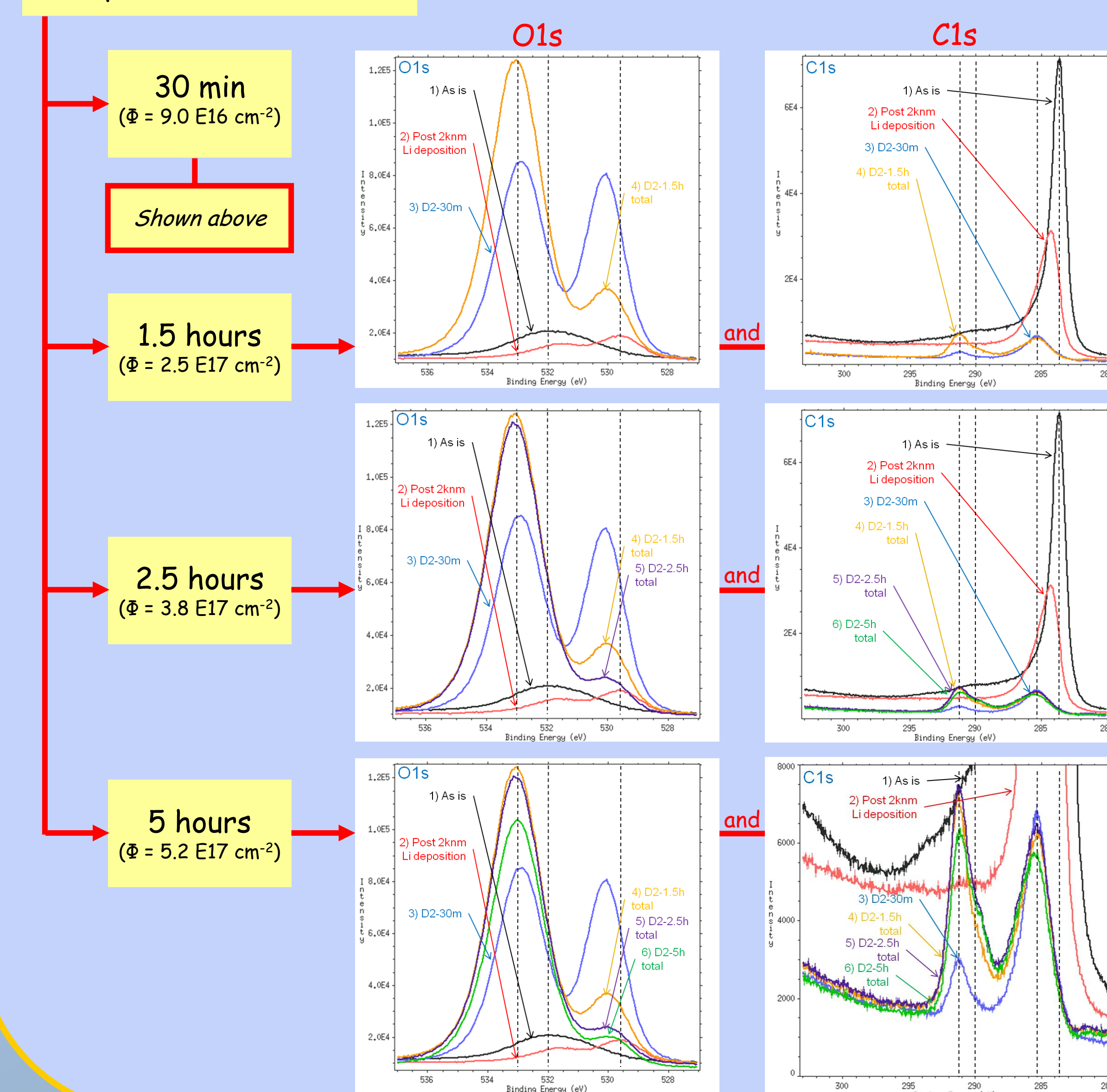
Oxygen:
Li and O interactions are manifest at 529.5 eV in the XPS spectrum.

Li, O, and D interactions, on a graphite substrate, are manifest at 533 eV.

Carbon:
Li, D, and C interactions are manifest at 291 eV.

Time dependent deuterium fluence affects dominating chemical bonds:

Incrementally increase deuterium fluence to observe changes and response threshold.



- Li-O-D peak (533 eV) increases
- Li-O peak (529.5 eV) decreases
- Li-C-D peak (291 eV) increases

Subsequent irradiations continue the trend. D related bonds clearly increase relative to neighboring peaks.

Changes in relative intensity slow at some D fluence threshold (as a function of Li thickness).

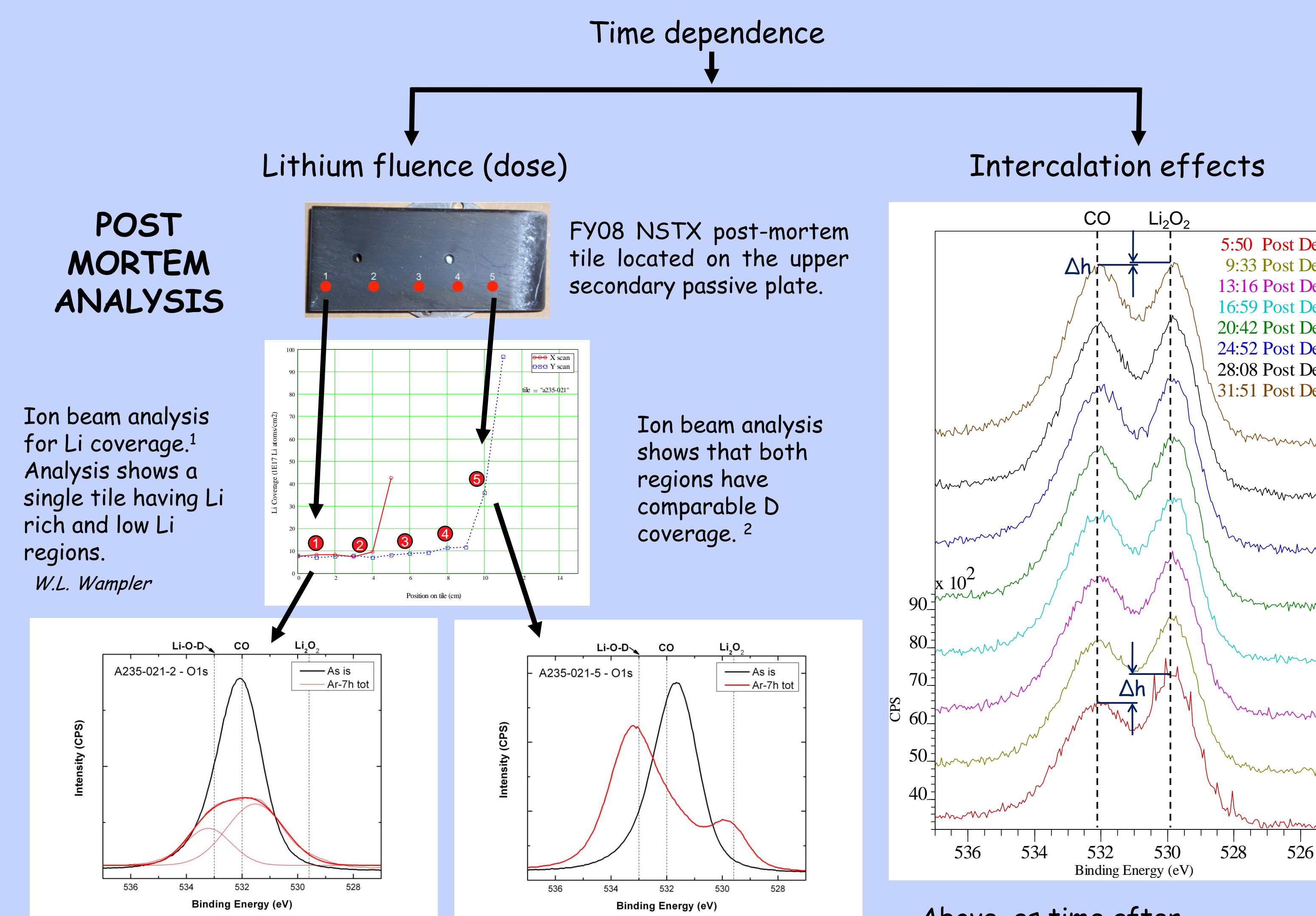
What changes are observed if lithium film thickness is <2µm?

Abstract

Lithium conditioning of plasma facing components has been used for particle control in fusion devices such as TFTR, CDX-U, FTU, T-11M, TJ-II and NSTX and has yielded improved plasma performance. A PMI probe has been installed on NSTX to provide an in-situ diagnostic for surface chemistry and deuterium retention measurements. Recent controlled laboratory experiments at Purdue University are investigating the chemical functionalities in lithiated graphite and the mechanism by which D is retained. XPS results show that Li reacts readily with residual oxygen in ATJ graphite, and immediately begins to intercalate into the substrate. Additionally, it has been found that Li-O and Li-C react to D proportional to the lithium thickness, suggesting a D saturation threshold. This work investigates the transient nature of the lithium and oxygen functionalities, their response to time varying D flux, and the implications to NSTX.

3 Lithium Dose Dependence

Surface chemistry is affected by time dependent parameters:



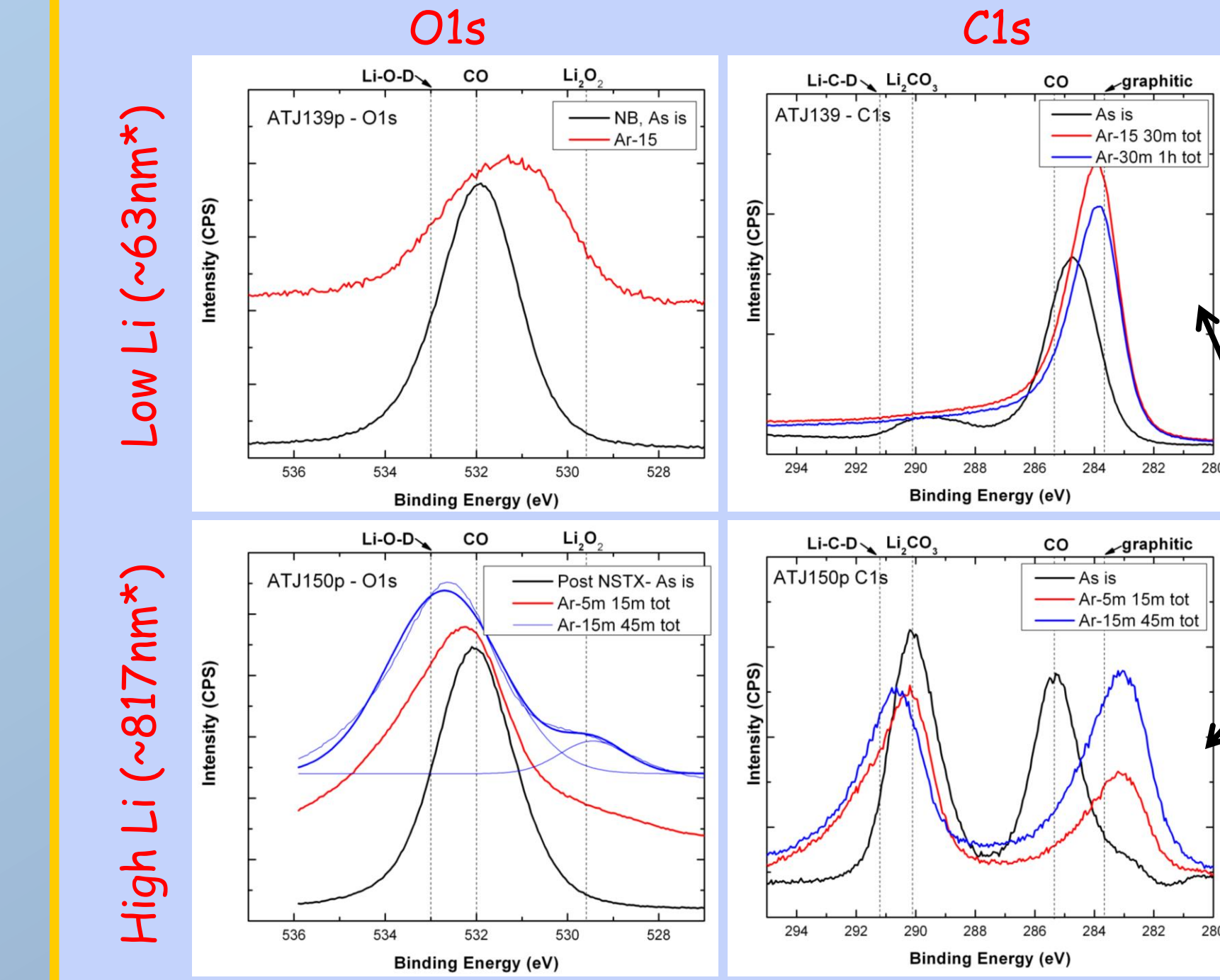
Low Li region on tile did not produce the functionalities characteristic of deuterium retention. Li rich region on the same tile produces the functionalities characteristic of deuterium retention. Intercalation of lithium is a time dependent function and has been studied extensively.³

How do sections 2 & 3 connect to PMI in NSTX?

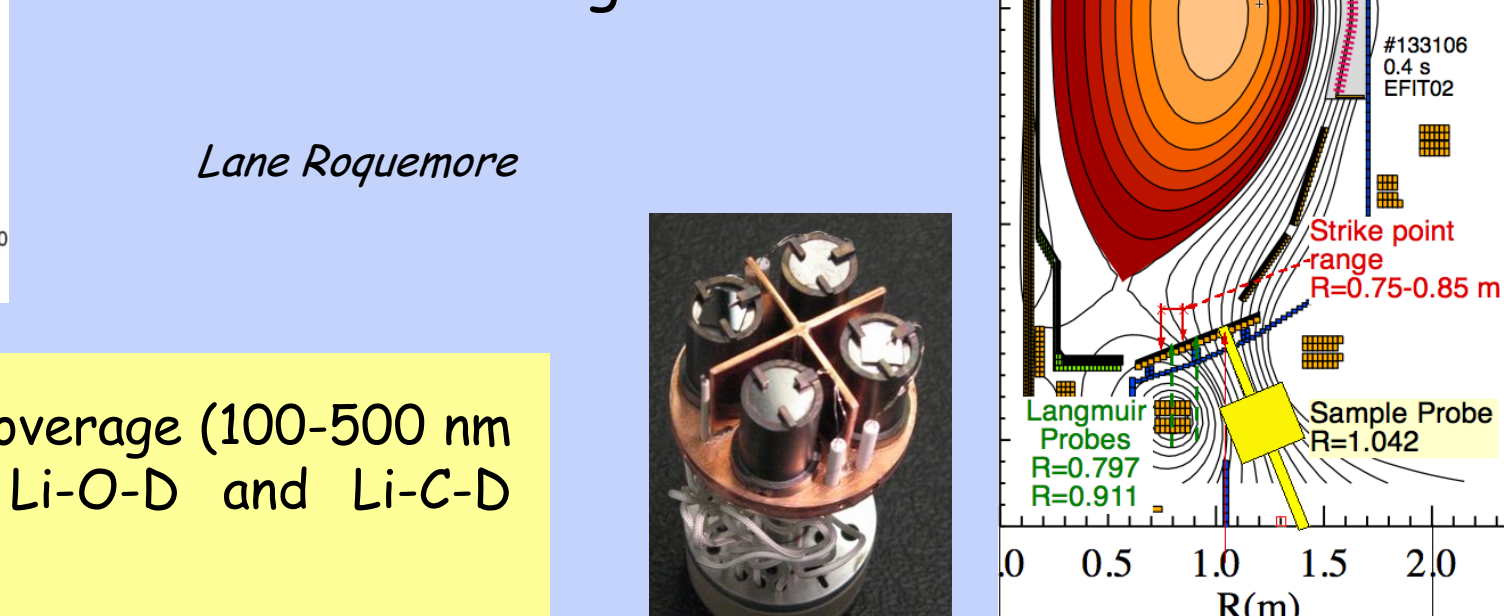
- Section 2: Controlled experiments show correlation between D retention and Li-C and Li-O bonding.
- Section 3: The amount of Li on surface dictates retention viability.
- Section 4: PMI probe elucidates on D-Li interactions.

4 PMI Probe Results

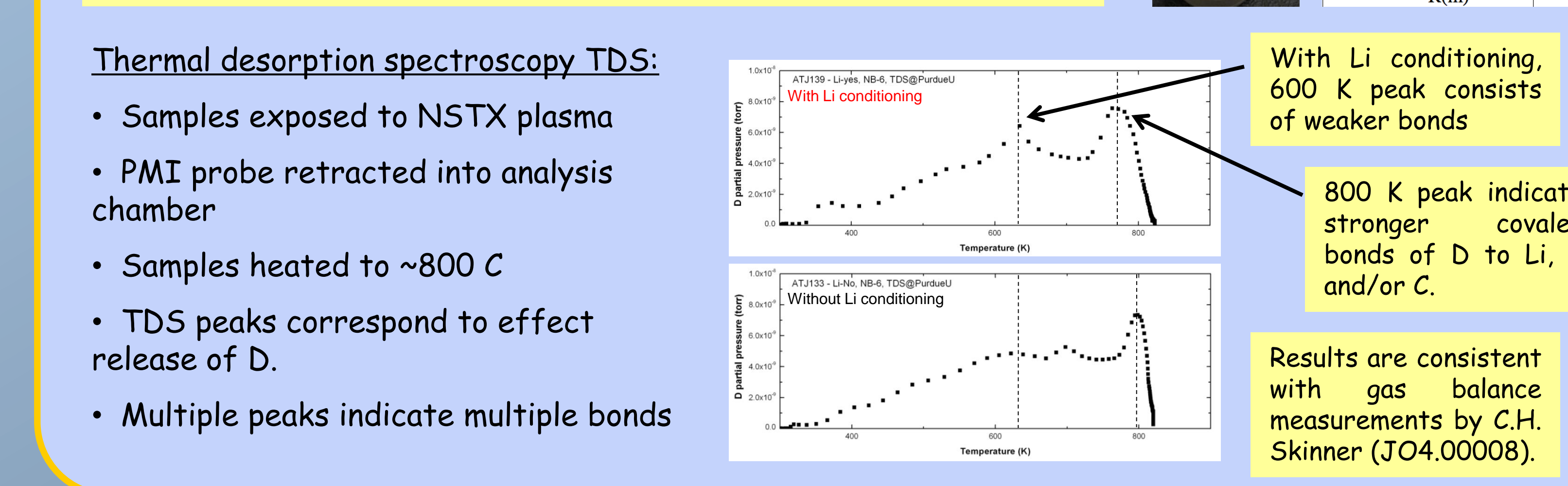
Samples were exposed to NSTX plasmas via PMI probe during several experiments. Samples provided shot by shot comparison of surface chemistry and D retention measurements.



- Experimental specifications:**
- 4 samples on a 2" dia. Probe (2x ATJ graphite, Si, and Si/Pd)
 - Secure, disruption-proof mechanical attachment
 - 16 thermocouple wires connections
 - Thermal cooling
 - 2 Langmuir probes
 - Heater connection(s)
 - Samples exposed to 6 NB heated discharges
 - ATJ exposed to 40 NB heated discharges



Samples exposed to NSTX plasmas with sufficient lithium coverage (100-500 nm for a polished surface) had peaks congruent to the Li-O-D and Li-C-D functionalities observed in control studies.



With Li conditioning, 600 K peak consists of weaker bonds. 800 K peak indicates stronger covalent bonds of D to Li, O, and/or C. Results are consistent with gas balance measurements by C.H. Skinner (JO4.00008).

5 Conclusions

- Lithium thickness is a fundamental parameter in deuterium retention. A nominal minimum threshold thickness exists between 100 and 500 nm.
- Lithium is always bound to oxygen and carbon, when present.
- Working hypothesis: D atoms are weakly bound (based on TDS and XPS analysis) in regions near lithium atoms bound to either oxygen or the carbon matrix (fundamentally different to non Li conditioned graphite).
- Li, O, and D interactions, on a graphite substrate, are manifest at 533 eV. Peak dominates with larger D fluence, indicating that a given lithium thickness has a finite deuterium capacity.
- Li, D, and C interactions are manifest at 291 eV. Relative peak energy increases with increased D fluence. Changes cease to occur at a presently unknown D fluence threshold.
- Li and O interactions, on a graphite substrate, are manifest at 529.5 eV in the XPS spectrum. Peak diminishes with larger D fluence, indicating that D⁺ binds with and consumes the Li-O bonds manifest at 529.5 eV.
- Future work will: 1) utilize Raman Spectroscopy to measure the D hybridization state, 2) study surface morphology effects.

Acknowledgements
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¹W.L. Wampler, "Ion Beam Analysis of Lithium on Tiles from NSTX" SNL, 2007.
²W.L. Wampler, "Ion Beam Analysis of Deuterium on Tiles from NSTX" SNL, 2007.
³N. Itou, H. Toyoda, K. Morita and H. Sugai, J. Nucl. Mater. 290 (2001), p. 281.